Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/710,828	EDELSTEIN ET AL.
Examiner	Art Unit

2814

Marcos D. Pizarro-Crespo

	SEARCHED				
Class	Subclass	Date	Examiner		
257	750-766	10/14/2006	MDP		
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INT	INTERFERENCE SEARCHED		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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